



IBM POUGHKEEPSIE

Diagnostic Engineering Publication

1410 / 7010

December 1, 1963

Subject: Diagnostic Program WT01B 1415 I/O Printer Test
Sequence Number 551
Replaces WT01A

When WT01 is in card form card # 001 is a System Control Card. It does not have any control information punched in it when it is released.

Refer to "1410/7010 Introduction", Volume 1.00 for instructions on how it must be punched.

This is a modified and improved version of WT01A. The modifications include:

- A. Changes necessary to be compatible with the current diagnostic format.
- B. Removal of the test routine called "WMS AND BLANKS IN M & L MODES."
- C. Alteration and expansion of the test routine called "WM ALIGNMENT AND WM PERIOD TESTS."
- D. Inclusion of a new test routine to check on band width (detenting difference) and alignment.
- E. Changing the timing section to type out the time it took to type each line instead of each pair of lines. The timing routine (now) covers 7010 as well as 1410 systems.
- F. Changing the method in which the optional "SELECTED CHARACTER ROUTINE" (build your own test pattern routine) operates.

Enclosures: 26 Pages
Card Deck for CARD ONLY SYSTEMS (as punched by UP51)
8 Cards - Card Loader (1-7) and 1 Core Clear
62 Cards No. 001-062 Data Cards
1 Card Execute Card

Distribution: X 1410
X 7010
Other



WT01

1415 CONSOLE I/O PRINTER TEST

(1410/7010)

December 1, 1963

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5.00.00.0 TEST DESCRIPTION

00.1 MODIFICATIONS

This is a modified and improved version of WT01A. The modifications include:

- A. Changes necessary to be compatible with the current diagnostic format. (Standard TADs at location 01000 and a Standard System Control Card to provide necessary system information and eliminate unnecessary operator intervention.)
- B. Removal of the test routine called "WMS AND BLANKS IN M & L MODES." This test routine contributed little to the overall effectiveness of the test.
- C. Alteration and expansion of the test routine called "WM ALIGNMENT AND WM PERIOD TESTS." See description, Section 5.00.00.2, for further information.
- D. Inclusion of a new test routine to check on band width (detenting difference) and alignment.
- E. Changing the timing section to type out the time it took to type each line instead of each pair of lines. The timing routine (now) covers 7010 as well as 1410 systems.
- F. Changing the method in which the optional "SELECTED CHARACTER ROUTINE" (build your own test pattern routine) operates. See OPERATING PROCEDURES, Section 5.00.02.2.

00.2 DESCRIPTION

WT01 is a functional test of the Program Printout Operations of the 1415 Console I/O Printer on the 1410 or 7010 Data Processing System. Test routines are directed toward checking Character Printout, Space, Word-Mark Control, and Carriage Return and Indexing Operations. The Input Operation is tested through the use of the Console Inquiry function.

5.00.00.0 TEST DESCRIPTION (continued)

Test patterns are designed to test specific operations or phases of operations. Before each pattern is typed, the title of the test pattern selection character is typed (see Section 5.00.02.2 for use of test pattern selection character).

The test patterns, their titles and test objectives are explained in the order in which they are run. Each test line of characters is typed twice for (visual) comparison.

COLLATING SEQUENCE A

Type all characters in the COLLATING SEQUENCE for convenient visual checking.

ROCK B

Test the tilt mechanism by typing the characters located one after the other in vertical columns on the print head.

ROLL C

Test the rotate mechanism by selecting characters one after the other in horizontal bands around the print head.

TWIST D

Test the combined rotate and tilt mechanism by causing a maximum rotation and tilt between characters.

WM ALIGNMENT AND WM PERIOD TESTS E

Exercise thoroughly spacing and backspacing mechanisms by typing word marks over every other character and then over every character. The word-mark period latch is given specific attention here.

BANDWIDTH & ALIGNMENT TEST F

The characters typed are chosen specifically to test band width (detenting difference), alignment and the action of the wear compensator. The characters, \$!QNLJ, are chosen because of their rotate selections. If a band width exists, it will be greatest among these characters. They are also used in a final check during alignment (fine tuning). The "JJ" is used extensively to cause the wear compensator to take up slack in the rotate and select system.

5.00.00.0 TEST DESCRIPTION (continued)

All test pattern selection characters should line up in position 42 on the margin scale as a test of the spacing operation.¹

Carriage return is always tested in two ways, by margin lever stop and again by a group mark word mark at the end of the write field. All fixed test patterns are 83 characters long. Because of the printout identification character (R normally) and the space that follows it, the first test pattern character is typed in position three and the last in position eighty-five if the tabs are set correctly. A carriage return and indexing operation is therefore initiated by both the B channel group mark word mark and an end of line condition. This produces a double space between each pair of lines of every test pattern. Look for this to occur.

00.3 EQUIPMENT

Any model 1410 or 7010 Data Processing System. The 1415 Console I/O Printer is the only I/O device tested. It is assumed to be on E channel only.

The Processing Overlap Feature is not necessary but is done in overlap mode if it is available.

00.4 CARD DECK

A complete card deck of WT01 consists of the following:

7 cards	Loader
1 card	Execute (Core Clear)
program cards ²	Program WT01
1 card	Execute (branch to 02000)

Note: Card No. 001 is a System Control Card. It does not have any control information punched in it when it is released. See "1410/7010 Introduction," Volume 1.00, for instructions on how to punch it.

00.5 EC LEVEL OF MACHINE

Not applicable.

- ¹ Be sure to follow instructions on setting up margin lever stops as explained in OPERATING PROCEDURES, Section 5.00.02.1.
- ² See Release sheet for exact number of cards.

5.00.01.0 LOADING PROCEDURES

Use Standard Diagnostic Loading Procedure. Refer to "1410/7010 Introduction," Volume 1.00, for further information.

5.00.02.0 OPERATING PROCEDURES

02.1 Always set the right and left hand margin lever stops to their maximum right and left hand positions (0 and 85, respectively). The test patterns and the character position count both depend on this. A group of four-digit numbers separated by slashes occurs in one line of this test for counting purposes. The units position of each number corresponds to the position of the character with respect to the left-hand margin. The printout identification character R is counted as number one.

WT01 begins immediately on completion of loading and no manual intervention is required.

02.2 Test operation can be altered at any time by using the "Program Alter Routine." An Inquiry Request is acknowledged upon completion of any line of type. TADs are loaded as blanks and the locations are only tested for 1. TAD5, a Special TAD, is an exception and its use is described fully.

Standard TADs

<u>TADs</u>	<u>Address</u>	<u>Not 1</u>	<u>1</u>
TAD0	01000	Do Not	Bypass Typeouts
TAD1	01001	Do Not	Loop on Routine
TAD2	01002	Do Not	Halt on Error
TAD3	01003	Do Not	Repeat Test

Special TADs

TAD4	01004	Do Not	Typeout time to type 1 line
TAD5	01005	Do Not	Select Test Pattern by letter

TAD 0 is used only to bypass an error message typeout.

Setting TAD 4 to a 1 causes a typeout of the time it took to type the line preceding it to be given. Use only on systems with the Processing Overlap Feature.

5.00.02.0 OPERATING PROCEDURES (continued)

Use TAD 5 to select a particular test pattern by name (actually by letter). If it remains a blank, all test routines are run in order. Entering the test pattern selection character (A, B, C, ... F) causes the test to go directly to the pattern selected. The test patterns and the letters that relate to them are covered in the description, Section 5.00.00.1. Entering an X causes the test to go to the "SELECTED CHARACTER ROUTINE." After entering an M or an L in response to "ENTER MODE- M OR L," the request "ENTER DATA FIELD" is made. At this time a full line of characters with or without word marks may be entered. If the number of characters entered is less than a full line (83), the portion entered is expanded to produce a full line typeout. To have less than a full line typed out, enter a group mark word mark after the last character to be typed. The line of characters is typed twice unless TAD1 is set to loop on routine. Entering a Z in TAD5 takes the program to the end of job message and into the next test.

5.00.03.0 OPERATING HINTS, COMMENTS

- 03.1 On systems equipped with overlap all test routines are typed in overlap mode. This makes it convenient to give typeouts of the length of time it takes to type a given line on request. If for some reason it is necessary to operate in unoverlap mode once the test is in progress, alter location 01263 to a blank (location denotes overlap in System Control Card), RESET and START. The test is started over from the beginning including the necessary initialization.

Should it ever be necessary to time (approximately) a carriage return operation instead of a normal line print operation, the following is offered. Use the SELECTED CHARACTER ROUTINE to type a simple line, preferably blanks (b's) in Load Mode or zeros (0's). Set TAD 1 to loop on routine (location 01001 to a 1) and TAD4 to a 1 for timing. With the right hand margin selector on 85 (end of line), take several lines of outputs. Now set the margin selector to 84. This causes a carriage return and the last character of the line to be typed in column 1. The time difference between the two lines is carriage return time (approximately).

¹. Timing can only be used on systems with the Processing Overlap Feature.

5.00.03.0 OPERATING HINTS, COMMENTS

03.2 The time for one pass of WT01 including all test routines, titles, etc., but no timing typeouts or Inquiry Requests is approximately 4 minutes.

03.3 The SELECTED CHARACTER ROUTINE can be used to investigate the Output Error Routine by entering a group mark word mark for the data field. This causes an underscored zero (0) followed by underscored blanks (b) to be typed. All characters are typed in column 1. Once this operation is initiated, it is not under program control and STOP or RESET must be used to terminate it.

5.00.04.0 PROGRAM STOPS, RESTARTS

There are no Normal Stops in WT01 and only one Error Stop. It is under TAD control and occurs only if TAD 2 is set to 1. The STOP follows an error typeout indicating a data check error. Push START to continue the test.

RESET and START causes the test to begin again at 02000, repeating the typeout of the test identification and performing all the initialization.

5.00.05.0 TYPEOUTS

05.1 The only typeout that has not been explained in preceding sections or may need clarification is:

***** DATA CHECK IN LAST LINE TYPED *****

This message indicates that a parity check error (Data Check) occurred during the typing of the test line above it. The character or characters involved should be underscored.

APPENDIX

1415 CONSOLE PRINTER

TRANSLATOR, OUTPUT

<u>BCD Bits</u>	<u>Magnet Picked</u>
$\bar{2}$	R1
$\bar{8} \cdot 4$	R2
$\bar{8} + 4$	R2A
$8 \cdot \bar{1} + \bar{8} \cdot 1$	R5
\bar{A}	T1
\bar{B}	T2
\bar{C}	CK
$8 \cdot 4 \cdot 2 \cdot 1 + 8 \cdot 4$	UC
All others	LC
v (Word Mark)	UC · CK
_ (Underscore)	UC · CK · T1 · T2

TRANSLATOR, INPUT

<u>Contacts Transferred</u>	<u>BCD Bit</u>
$R5 \cdot \overline{R2A} \cdot LC + \overline{R5} \cdot R2A + \overline{R5} \cdot UC$	1
$R1 \cdot \overline{R2A} + LC \cdot R1$	2
$R2 \cdot \overline{R2A}$	4
$R2A \cdot LC + \overline{R2A} \cdot UC$	8
T1	A
T2	B
CK + Space	C
Word Mark	WM

Contracts transfer when corresponding magnet is NOT picked, except R5 which transfers when magnet is picked.

Keyboard to contact coding is same as magnets picked.

1415 CONSOLE PRINTER

Character	BCD Code					Magnets Picked							
b (Blank)	C					R1	R2	R2A		T1	T2	UC	*
. (Period)		B	A	8	2 1							C	LC
)	C	B	A	8 4		R1		R2A	R5				UC
[B	A	8 4	1	R1		R2A				C	UC
<		B	A	8 4 2				R2A	R5			C	UC
‡ (Group Mark)	C	B	A	8 4 2 1				R2A					UC
& (Ampersand) +	C	B	A			R1	R2	R2A					UC *
\$	C	B		8 2 1						T1			LC
*		B		8 4		R1		R2A	R5	T1		C	UC
]	C	B		8 4 1		R1		R2A		T1			UC
;	C	B		8 4 2				R2A	R5	T1			UC
Δ		B		8 4 2 1				R2A		T1		C	UC
-		B				R1	R2	R2A		T1		C	UC *
/	C	A			1	R1	R2	R2A	R5		T2		LC *
, (Comma)	C	A	8	2 1							T2		LC
% ()		A	8 4			R1		R2A	R5		T2	C	UC
~ (Wd Separator)	C	A	8 4	1		R1		R2A			T2		UC
\	C	A	8 4 2					R2A	R5		T2		UC
‡ Segment Mark		A	8 4 2 1					R2A			T2	C	UC
Ⓢ Substitute		A				R1	R2	R2A			T2	C	UC *
‡ Blank =			8 2 1							T1	T2	C	LC
@ ,	C		8 4			R1		R2A	R5	T1	T2		UC
:			8 4 1			R1		R2A		T1	T2	C	UC
>			8 4 2					R2A	R5	T1	T2	C	UC
√ (Tape Mark)	C		8 4 2 1					R2A		T1	T2		UC
?	C	B	A	8 2					R5				LC
A		B	A		1	R1	R2	R2A	R5			C	LC
B		B	A		2		R2	R2A				C	LC
C	C	B	A		2 1		R2	R2A	R5				LC
D		B	A	4		R1		R2A				C	LC
E	C	B	A	4 1		R1		R2A	R5				LC
F	C	B	A	4 2				R2A					LC
G		B	A	4 2 1				R2A	R5			C	LC
H		B	A	8		R1			R5			C	LC
I	C	B	A	8 1		R1							LC
J		B		8 2					R5	T1		C	LC
K	C	B			1	R1	R2	R2A	R5	T1			LC
L	C	B			2		R2	R2A		T1			LC
M		B			2 1		R2	R2A	R5	T1		C	LC
N	C	B		4		R1		R2A		T1			LC
O		B		4 1		R1		R2A	R5	T1		C	LC
P	C	B		4 2				R2A		T1		C	LC
			4 2 1					R2A	R5	T1			LC

* From keyboard R5 selected instead of R1, R2, R2A.

1415 Console Printer (continued)

Character	BCD Code				Magnets Picked							
	C	B	8		R1		R5	T1				LC
Q	C	B	8		R1		R5	T1				LC
R		B	8	1	R1			T1		C		LC
# (Record Mark)		A	8	2			R5		T2	C		LC
S	C	A		2	1	R2	R2A	R5	T2	C		LC
T		A		2	1	R2	R2A	R5	T2	C		LC
U	C	A	4		R1		R2A		T2			LC
V		A	4	1	R1		R2A	R5	T2	C		LC
W		A	4	2			R2A		T2	C		LC
X	C	A	4	2	1		R2A	R5	T2			LC
Y	C	A	8		R1			R5	T2			LC
Z		A	8	1	R1				T2	C		LC
0	C		8	2				R5	T1	T2		LC
1				1	R1	R2	R2A	R5	T1	T2	C	LC
2				2		R2	R2A		T1	T2	C	LC
3	C			2	1	R2	R2A	R5	T1	T2		LC
4			4		R1		R2A		T1	T2	C	LC
5	C		4	1	R1		R2A	R5	T1	T2		LC
6	C		4	2			R2A		T1	T2		LC
7			4	2	1		R2A	R5	T1	T2	C	LC
8			8		R1			R5	T1	T2	C	LC
9	C		8	1	R1				T1	T2		LC
∨ (Word Mark)											C	UC
_ (Underscore)									T1	T2	C	UE

I/O PRINTER TEST

CT ADDR INSTRUCTION

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDR	INSTRUCTION
1002	LOADER	EQU	400			
1003						
1004		*****	STANDARD TADS			*****
1005		ORG	1000		01000	
1006			NOT 1			1
1007	TAD0	DC	2 2	1	01000	BYPASS TYPE OUTS
1008	TAD1		2 2	1	01001	LOOP ON ROUTINE
1009	TAD2		2 2	1	01002	HALT ON ERRORS
1010	TAD3		2 2	1	01003	REPEAT PROGRAM

TEST SET UP IN THE NOT 1 CONDITION
AND WILL ONLY CHECK FOR A 1

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDR	INSTRUCTION
1011						
1012						
1013						
1014						
1015		*****	SPECIAL TADS			*****
1016						
1017	TAD4	DC	2 2	1	01004	TYPEOUT TIME TO TYPE 1 LINE
1018						USE ONLY IF SYSTEM HAS OVERLAP
1019	TAD5		2 2	1	01005	SELECT TEST PATTERN BY LETTER

* THE FOLLOWING MAY BE USED IN
TADS TO SELECT TEST PATTERNS

- A TEST A COLLATING SEQUENCE
- B TEST B ROCKING EXERCISE
- C TEST C ROLLING EXERCISE
- D TEST D TWISTING EXERCISE
- E TEST E WORDMARK ALIGNMENT
- F TEST F BANDWIDTH-ALIGNMENT
- X TEST X SELECTED CHARACTERS
- Z THEEND EOJ MESSAGE & B 400

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDR	INSTRUCTION
1020						
1021						
1022						
1023						
1024						
1025						
1026						
1027						
1028						
1029						
1030						
1031	GMM	DCW	6 2MA	1	01006	

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1033	•		•PROGRAM ALTER AND CONTROL ROUTINE			
1034						
1035	CONTRL	SBR	CTLXIT&S	7	01007	G 01081 B
1036	ENTER	RCP	ADDRESS&4	10	01014	M XTO 01049 R
1037		BNTI	CTLXIT Y	7	01024	R 01076 B
1038		BEXI	ENTER,M	7	01031	R 01014 T
1039		BAI	ADDRES	7	01038	R 01045 M
1040	ADDRES	RCPW	00000	10	01045	L XTO 00000 R
1041		BEXI	ADDRES,M	7	01055	R 01045 S
1042		BAI	*&I	7	01062	R 01069 M
1043						
1044		B	TSTSEL	7	01069	J 01083
1045						
1046	CTLXIT	B	00000	7	01076	J 00000
1047	•					
1048	•					
1049	•					
1050	TSTSEL	BCE	TESTA,TAD5,A	12	01083	B 02007 01005 A
1051		BCE	TESTB,TAD5,B	12	01095	B 02160 01005 B
1052		BCE	TESTC,TAD5,C	12	01107	B 02251 01005 C
1053		BCE	TESTD,TAD5,D	12	01119	B 02342 01005 D
1054		BCE	TESTE,TAD5,E	12	01131	B 02433 01005 E
1055		BCE	TESTF,TAD5,F	12	01143	B 02555 01005 F
1056		BCE	TESTX,TAD5,X	12	01155	B 02653 01005 X
1057		BCE	THEEND,TAD5,Z	12	01167	B 02993 01005 Z
1058		B	CTLXIT	7	01179	J 01076
1059	H		DEFINE PRECEDING BRANCH LENGTH	1	01186	•



PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1061		ORG	1230		01230	CONTROL INFORMATION
1062		DC	a	15	01244	
1063		DC	255100a	5	01249	SEQ# 551 SK SYSL ONLY
1064	TESTIO	DCW	2HT01a	4	01253	*TEST IDENTIFICATION
1065	LEVEL	DC	282.G	1	01254	
1066						
1067		ORG	1256		01256	*SYSTEM CONTROL CARD
1068	SYSL	DC	a a	1	01256	INDICATE SYSTEM TYPE
1069						0 1410 STD
1070						I 1410 ACC
1071						X 7010
1072		a	a	6	01262	NOT INTERROGATED
1073		a a		1	01263	I-SYSTEM HAS OVERLAP
1074		a	a	15	01278	NOT INTERROGATED
1075		a	a	10	01288	
1076		ORG	1289		01289	
1077						
1078						UTILITY TYPING AND SPACING ROUTINE
1079						
1080	TYPEIT	SBR	TYPE&8	7	01289	G 01304 B
1081	TYPE	WCP	00000	10	01296	M 2TO 00000 W
1082		SBR	TYPEXT&5	7	01306	G 01383 B
1083		BCB1	TYPE	7	01313	R 01296 Z
1084		BA1	*C1	7	01320	R 01327 M
1085		CW	SPACE&1	6	01327	B 01358
1086	SPACE	SBR	SPACE&6	7	01333	G 01363 B
1087		WCP	ABLANK	10	01340	M 2TO 01385 W
1088		BA1	*-16	7	01350	R 01340 M
1089	SPACEX	NCPWM		1	01357	N
1090		B	00000	7	01358	J 00000
1091		SW	SPACE&1	6	01365	* 01358
1092		BNQ	CONTRL	7	01371	J 01007 Q
1093	TYPEXT	B	00000	7	01378	J 00000
1094						
1095	ABLANK	DCW	a a.G	1	01385	JUST FOR A SPACE

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1097	.		INITIALIZATION- DONE ON FIRST PASS ONLY			
1098	SETUP	CS	99	6	01387	/ 00099
1099		MRCWG	B2000,I	12	01393	D 01612 00001 L
1100		SW	95,25	11	01405	, 00095 00025
1101		MLWB	95,90	12	01416	D 00095 00090 M
1102		ZA	OTIME,TIME	11	01428	M 01703 03587
1103		BCE	CK4DLP,SYSL,0	12	01439	B 01485 01256 0
1104		ZA	ITIME,TIME	11	01451	M 01707 03587
1105		BCE	CK4DLP,SYSL,I	12	01462	B 01485 01256 I
1106		ZA	XTIME,TIME	11	01474	M 01711 03587
1107	CK4DLP	BCE	*619,SYSL67,	12	01485	B 01515 01263
1108		SW	OVLAP61	6	01497	, 03209
1109		MLCS	666,TYPEP61	12	01503	D 04436 03199 3
1110		SW	PATRNXE84	6	01515	, 04436
1111		SAR	ENDOFX	7	01521	G 00049 A
1112		SW	TWIGP640	6	01528	, 04056
1113		SW	SPBSP1,SPBSP1682	11	01534	, 04100 04182
1114		SW	SPBSP2,SPBSP2682	11	01545	, 04184 04266
1115		MLWB	SPBSP1682,SPBSP1680	12	01556	D 04182 04180 M
1116		MLWB	SPBSP2682,SPBSP2681	12	01568	D 04266 04265 M
1117		MLCS	666,ENTERX69	12	01580	D 04437 02797 3
1118		B	TYPEIT	7	01592	J 01289
1119		DCW	6WT01B6,G	5	01603	
1120		B	TESTA	7	01605	J 02007
1121			BEGIN TEST PATTERN SEQUENCE			
1122						
1123	62000	DCW	6JC2000 6,G	7	01612	RESET RESTART
1124		ORG	*6X00		01700	
1125	OTIME	DCW	60167	4	01703	U SEC/PASS IN TIMING LOOP 1410
1126	ITIME		60133	4	01707	U SEC/PASS IN TIMING LOOP 1410I
1127	XTIME		60047	4	01711	U SEC/PASS IN TIMING LOOP 7010

I/O PRINTER TEST

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PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1129		ORG	2000		02000	PROGRAM STARTS HERE
1130	START	B	SETUP	7	02000	J 01387
1131						
1132						
1133	TESTA	B	SPACE	7	02007	J 01333
1134		B	TYPEIT	7	02014	J 01289
1135		DCW	COLLATING SEQUENCE	40	02060	A3.G
1136						
1137	TYPEA	B	WCP	7	02062	J 03100
1138		DCW	CSGP1	5	02073	03596
1139		B	WCP	7	02074	J 03100
1140		DCW	CSGP1	5	02085	03596
1141						
1142		B	SPACE	7	02086	J 01333
1143		B	WCP	7	02093	J 03100
1144		DCW	CSGP2	5	02104	03680
1145		B	WCP	7	02105	J 03100
1146		DCW	CSGP2	5	02116	03680
1147						
1148		B	SPACE	7	02117	J 01333
1149		B	WCP	7	02124	J 03100
1150		DCW	CSGP3	5	02135	03764
1151		B	WCP	7	02136	J 03100
1152		DCW	CSGP3	5	02147	03764
1153						
1154		BCE	TYPEA,TAD1.1	12	02148	B 02062 01001 1

REPEAT PATTERN A

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1156	TESTB	B	SPACE	7	02160	J 01333
1157		B	TYPEIT	7	02167	J 01289
1158		DCW	BRCK	40	02213	B,G
1159						
1160	TYPEB	B	WCPW	7	02215	J 03115
1161		DCW	ROKGP	5	02226	03848
1162		B	WCPW	7	02227	J 03115
1163		DCW	ROKGP	5	02238	03848
1164						
1165		BCE	TYPEB,TADI,I	12	02239	B 02215 01001 I
1166	*					
1167	*					*****
1168	*					
1169	TESTC	B	SPACE	7	02251	J 01333
1170		B	TYPEIT	7	02258	J 01289
1171		DCW	ROLL	40	02304	C,G
1172						
1173	TYPEC	B	WCPW	7	02306	J 03115
1174		DCW	ROLGP	5	02317	03932
1175		B	WCPW	7	02318	J 03115
1176		DCW	ROLGP	5	02329	03932
1177						
1178		BCE	TYPEC,TADI,I	12	02330	B 02306 01001 I
1179	*					
1180	*					*****
1181	*					
1182	TESTD	B	SPACE	7	02342	J 01333
1183		B	TYPEIT	7	02349	J 01289
1184		DCW	TWIST	40	02395	D,G
1185						
1186	TYPED	B	WCPW	7	02397	J 03115
1187		DCW	TWTGP	5	02408	04016
1188		B	WCPW	7	02409	J 03115
1189		DCW	TWTGP	5	02420	04016
1190						
1191		BCE	TYPED,TADI,I	12	02421	B 02397 01001 I

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADORS	INSTRUCTION
1193	TESTE	B	SPACE	7	02433	J 01333
1194		B	TYPEIT	7	02440	J 01289
1195		DCW	2MM ALIGNMENT AND MM PERIOD TESTS E2,G	40	02486	
1196						
1197	TYPEE	B	WCPW	7	02488	J 03115
1198		DCW	SPBSP1	5	02499	04100
1199		B	WCPW	7	02500	J 03115
1200		DCW	SPBSP1	5	02511	04100
1201						
1202		B	SPACE	7	02512	J 01333
1203		B	WCPW	7	02519	J 03115
1204		DCW	SPBSP2	5	02530	04184
1205		B	WCPW	7	02531	J 03115
1206		DCW	SPBSP2	5	02542	04184
1207						
1208		BCE	TYPEE,TA01.1	12	02543	B 02488 01001 1
1209						
1210						
1211						
1212	TESTF	B	SPACE	7	02555	J 01333
1213		B	TYPEIT	7	02562	J 01289
1214		DCW	BANDWIDTH & ALIGNMENT TEST F2,G	40	02608	
1215						
1216	TYPEF	B	WCP	7	02610	J 03100
1217		DCW	BWAGP	5	02621	04268
1218		B	WCP	7	02622	J 03100
1219		DCW	BWAGP	5	02633	04268
1220						
1221		BCE	TYPEF,TA01.1	12	02634	B 02610 01001 1
1222						
1223						
1224		B	THEEND	7	02646	J 02993

TEST X DONE ON REQUEST ONLY

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1226	TESTX	B	SPACE	7	02653	J 01333
1227		B	TYPEIT	7	02660	J 01289
1228		DCW	@SELECTED CHARACTER ROUTINE	40	02706	X@,G
1229						
1230		S	BUMPI	6	02708	S 00069
1231		B	TYPEIT	7	02714	J 01289
1232		DCW	@ENTER MODE- M OR L@,G	18	02738	
1233		RCPW	MODE S	10	02740	L XTO 03419 R
1234		BEX1	*-16,M	7	02750	R 02740 M
1235		BAI	*@1	7	02757	R 02764 M
1236		B	TYPEIT	7	02764	J 01289
1237		DCW	@ENTER DATA FIELD@,G	16	02786	
1238	ENTERX	RCPW	PATRX	10	02788	L XTO 04352 R
1239						
1240		SBR	NEXT1 S	7	02798	G 00059 B
1241		BEX1	*-23,M	7	02805	R 02788 M
1242		BAI	*@1	7	02812	R 02819 M
1243		C	NEXT1,@PATRX	11	02819	C 00059 04442
1244		BE	TYPEX	7	02830	J 02914 S
1245		S	@1,NEXT1	11	02837	S 04443 00059
1246	CK4END	C	NEXT1,ENDOFX	11	02848	C 00059 00049
1247		BE	TYPEX	7	02859	J 02914 S
1248	EXPAND	MLCWS	PATRX@BUMPI,@NEXT1	12	02866	D 04LV2 004M0 7
1249		SBR	NEXT1	7	02870	G 00059 B
1250		A	@1,BUMPI	11	02885	A 04443 00069
1251		A	@2,NEXT1	11	02896	A 04444 00059
1252		B	CK4END	7	02907	J 02848

ZERO INDEX REGS USED TO COUNT

ENTER MODE - M OR L

TRY AGAIN ON 1/2/4/8/A

ENTER CHARACTERS FOR PATTERN

ENTER GMM FOR SHORT LINE

STORE ADDR OF LAST CHAR ENTERED@1

TRY AGAIN ON 1/2/4/8/A

SEE IF ANY ENTRY WAS MADE

NO TYPE OLD PATTERN

REDUCE B ADDR REG BY 1

CHECK FOR END OF PATTERN

OK TYPE IT

EXPAND TO FULL LINE

STORE ADDR OF LAST CHAR ENTERED@1

ADD TO COUNTERS

STEP TO NEXT LOCATION

SEE IF ITS ALL DONE

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1254	TYPEX	BCE	LMODE,MODE,L	12	02914	8 02957 03419 L
1255		B	WCP	7	02926	J 03100
1256		DCW	PATRX	5	02937	04352
1257		B	WCP	7	02938	J 03100
1258		DCW	PATRX	5	02949	04352
1259		B	*L25	7	02950	J 02981
1260						
1261	LMODE	B	WCPW	7	02957	J 03115
1262		DCW	PATRX	5	02968	04352
1263		B	WCPW	7	02969	J 03115
1264		DCW	PATRX	5	02980	04352
1265						
1266		BCE	TYPEX,TA01,1	12	02981	8 02914 01001 1
1267						
1268						
1269						
1270	THEEND	B	TYPEIT	7	02993	J 01289
1271		DCW	2	48	03047	
1272		BNQ	CONTRL	7	03049	J 01007 0
1273		BCE	TESTA,TA03,1	12	03056	8 02007 01003 1
1274		B	LOADER	7	03068	J 00400
1275		H		1	03075	.
1276						
1277		ORG	*LX00			03100

*** END OF JOB ***2.G

ANY LAST REQUEST

REPEAT TEST-NO INITIALIZATION

ON TO NEXT PROGRAM

DEFINE PRECEDING BRANCH LENGTH

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1279	*		TEST PATTERN TYPING ROUTINE			
1280						
1281	WCP	SBR	DATA	7	03100	G 00039 B
1282		B	SETOP	7	03107	J 03130
1283		DCW	2M2	1	03114	
1284						
1285	WCPW	SBR	DATA	7	03115	G 00039 B
1286		B	SETOP	7	03122	J 03130
1287		DCW	2L2	1	03129	
1288						
1289	SETOP	SBR	*66	7	03130	G 03142 B
1290		MLCHS	0, TYPETP	12	03137	D 00000 03198 7
1291		CH	6&DATA	6	03149	□ 000M6
1292		SAR	RETURN	7	03155	G 00029 A
1293		S	TOTAL	6	03162	S 03595
1294		CS	BUFFER&82	6	03168	/ 03582
1295		MLNA	4&DATA,*66	12	03174	D 000M4 03191 /
1296		MRCWG	0, BUFFER	12	03186	D 00000 03500 L
1297	TYPETP	WCPW	BUFFER	10	03198	L %TO 03500 W
1298	OVLAP	NOPWM		1	03208	N
1299		B0L1	TIMER	7	03209	J 03230 1
1300		B0B1	TYPETP	7	03216	R 03198 2
1301		B	CK4ERR	7	03223	J 03248
1302	TIMER	A	TIME, TOTAL	11	03230	A 03587 03595
1303		B0L1	*-17	7	03241	J 03230 1
1304	CK4ERR	BA1	ERRORT	7	03248	R 03328 M
1305		BCE	EDITIT, TA04, 1	12	03255	B 03274 01004 1
1306		B	CK4INQ	7	03267	J 03314
1307	EDITIT	MLCWA	CTLFLD, RESULT&4	12	03274	D 03425 03430 X
1308		MCE	TOTAL-4, RESULT&4	11	03286	E 03591 03430
1309		WCP	RESULT	10	03297	M %TO 03426 W
1310		BA1	*-16	7	03307	R 03297 M
1311	CK4INQ	BNQ	CONTRL	7	03314	J 01007 Q
1312		B	O&RETURN	7	03321	J 00040

I/O PRINTER TEST

PGLIN	LABEL	OPCODE	OPERAND	CT	ADDRS	INSTRUCTION
1314	*		ERROR ROUTINE			
1315						
1316	ERROR	BCE	CK4HLT,TAD0,1	12	03328	B 03392 01000 I
1317		B	TYPEIT	7	03340	J 01289
1318		DCW	2** DATA CHECK IN LAST LINE TYPED **2.G	37	03383	
1319		BNQ	CONTRL	7	03385	J 01007 Q
1320	CK4HLT	BCE	HALT,TAD2,1	12	03392	B 03411 01002 I
1321		B	*62	7	03404	J 03412
1322	HALT	H		1	03411	.
1323		B	CK4INQ	7	03412	J 03314
1324						
1325	*		CONSTANTS, OUTPUT AREA			
1326						
1327	MODE	DCW	2 2.G	1	03419	
1328	CTLFLD		2 . 02	5	03425	
1329	RESULT		2 . SECS2.G	10	03426	
1330						
1331		ORG	*6X00		03500	
1332	BUFFER	DA	1X83.G		03500	
1333	TIME	DCW	60C00	4	03587	
1334	TOTAL		2000000002	8	03595	

INSTRUCTION

CT

ADDRS

OPCODE

LABEL

PGLIN

OPERAND

PGLIN	LABEL	OPCODE	OPERAND	CT	ADDRS	INSTRUCTION
1336	*		TEST PATTERNS			
1337						
1338	CSGP1	DC	2 LL LL GG RR :: DD BB SS SS BB :: LL -- // .. 3X SSA GG TT QQ TT MM MM /00852.G	50	03596	
1339				33	03678	
1340	CSGP2		2AA BB CC DD EE FF GG HH II :: JJ KK LL MM NN OO PPA	50	03680	
1341				33	03762	
1342	CSGP3		2 CQ RR ## SS TT UU VV WW XX YY ZZA.G	50	03764	
1343				33	03846	
1344	ROKGP		2#\$. IRZ96WOFDMU42SKBM.*08YQHGPX75VNECLT31/JAMMLMBB@ W.S L.BG TSDGLR	50	03848	
1345				33	03930	
1346	ROLGP		2#9642087531M: T2XSSM/TVXY*SUMZ,\$RCMK.QPNLJLB-,*DTA L.G BSHS DR .L	50	03932	
1347				33	04014	
1348	TWTGP		2@BMACEGHMBDFI.\$.#9642087531M: Y22.G L.BG Q.S L.R.W T.S.D.G	50	04016	
1349				33	04098	
1350	SPBSP1		2M6FMD.M GTE@EN.V05T7SXA.A.A.A.A.G D DDD	50	04100	
1351				33	04182	
1352	SPBSP2		2IIIIIMMM...YYY...WWW*##XXXLLLLLVVV...VVVVLLLa D DDD MMMIIIIa.G	50	04184	
1353				33	04266	
1354	BWAGP		2JJLNQ.\$JJJJJJJJLNQ.\$JJJJJJJJLNQ.\$JJJJJJJJLNQ@	50	04268	
1355				33	04350	
1356	PATRNX		2\$.JJJJJJJJLNQ.\$JJJJJJJJLNQ.\$Ja.G	50	04352	
1357				33	04434	
1358						
1359	RETURN	EQU	1,X ADDR OF RETURN TO TEST ROUTINE			
1360	DATA	EQU	3,X ADDR OF DATA FIELD TO BE TYPED			
1361	ENDOFX	EQU	5,X ADDR OF END OF TEST X PATTERN			
1362	NEXTI	EQU	7,X ADDR REG USED IN TEST X EXPANSION			
1363	BUMPI	EQU	9,X COUNT TO EXPAND PATTERN IN TEST X			
1364						
1365		END	START		J02000	
1365			222	1	04436	
1365			252	1	04437	
1365			PATRNX	5	04442	04352
1365			61	1	04443	
1365			62	1	04444	

END OF ASSEMBLY

SUMMARY

SET UP

Set right and left hand margin selector tabs to their maximum positions, 0 and 85 on the margin scale, respectively.

LOADING

Use standard 1410/7010 Diagnostic Loading Procedure. Refer to "1410/7010 Introduction," Volume 1.00, for additional information.

CONTROL

The following Standard and Special TADs are available for program control. None need be set to run this test.

<u>TADs</u>	<u>Address</u>	<u>Not 1</u>	<u>1</u>
TAD 0	01000	Do Not	Bypass Typeouts
TAD 1	01001	Do Not	Loop on Routine
TAD 2	01002	Do Not	Halt on Error
TAD 3	01003	Do Not	Repeat Test
TAD 4	01004	Do Not	Typeout time to type 1 line (use only if system has overlap)
TAD 5	01005	Do Not	Select Test Pattern by letter

The following may be used in TAD 5 to select test patterns:

A Test A COLLATING SEQUENCE
B Test B ROCKING EXERCISE
C Test C ROLLING EXERCISE
D Test D TWISTING EXERCISE
E Test E WORDMARK ALIGNMENT
F Test F BANDWIDTH-ALIGNMENT
X Test X SELECTED CHARACTERS
Z THE END EOJ MESSAGE & B 400

SUCCESS INDICATIONS

No error typeout, test patterns A through F typed-all pass visual inspection, and the end of job message.

ERROR INDICATIONS

Only one error typeout is given:

*** DATA CHECK IN LAST LINE TYPED ***

All other error indications are in the form of incorrectly typed test patterns, character alignment and positioning, etc., and can only be found through careful visual inspection of the typed page(s).